

# **Classification of Surface Defects using Semi-Supervised Deep Learning**

## Introduction

In manufacturing, quality control is a process that ensures customers receive defect-free products. Defect identification is commonly performed manually by trained workers by visual inspection. But it is subjective, unreliable and time consuming. To overcome this, vision based Automatic surface inspection (ASI) methods are proposed, as they are fast, highly accurate and significantly reduces labor intensity. In this work, a Convolutional Neural Network based semisupervised learning approach is proposed for the recognition of surface defects as it requires little amount of labeled data compared to fully supervised approaches.

#### **Our contribution of this work are:**

- We propose a semi-supervised deep learning approach for the classification of surface defects.
- We propose a sample weighting strategy based on how well each unlabeled sample is predicted.

Our proposed approach achieves State-of-the-art results on three public datasets with limited amount of training data.

Comparison of funry supervised (FS) vs. semi-supervised (SS) approaches on different datasets										
Dataset	Backbone	FS/SS	<b>Overall accuracy (%) for different number of training samples per cla</b>							
			5% 10% 25%		50%	100%				
NEU	Resnet-10	FS	$91.69 \pm 1.52$	$97.00\pm0.09$	$99.45\pm0.26$	$99.67\pm0.17$	$99.86 \pm 0.11$			
		SS	98.34 ± 0.36	$99.50\pm0.12$	<b>99.75</b> ± 0:14	$99.82 \pm 0.05$	-			
Kolektor SDD	Resnet-10	FS	$79.94 \pm 4.37$	85.59 ± 1.13	$100 \pm 0.00$	$100 \pm 0.00$	$100 \pm 0.00$			
		SS	$\textbf{85.10} \pm \textbf{2.24}$	$88.60 \pm 0.69$	$100 \pm 0.00$	$100 \pm 0.00$	-			
Textures	Resnet-18	FS	$86.71 \pm 0.45$	$93.58\pm0.38$	$96.62\pm0.32$	$99.09\pm0.05$	$99.52 \pm 0.13$			
		SS	$89.52 \pm 0.48$	$95.33 \pm 0.28$	$\textbf{98.60} \pm \textbf{0.20}$	$99.50 \pm 0.01$	-			

In this experiment, we randomly select s% of images (s is varied from 5% to 100%). FS Approach: we used s% of labeled samples only from the training set for training. SS Approach: In addition to the s% of labeled samples, the remaining images from the training set are used as unlabeled samples for training.

Semi-supervised learning gives significant improvements over fully supervised learning on all the three datasets.

- On the NEU dataset, our approach achieves the state-of-the-art results with 10% of labeled training data.
- On the KolektorSDD dataset, our approach achieves the state-of-the-art results with 25% of labeled training data.
- In addition, on the **Surface Textures dataset**, we achieve the state-of-the-art results with only 50% of labeled training data.

## Conclusion

- This work proposed a simple and efficient semi-supervised deep learning approach for the classification of surface defects.
- Our approach is not specific to a particular CNN architecture, and any CNN architecture can be easily incorporated.
- The proposed semi-supervised learning approach performs better than its fully-supervised version.
- Our approach achieves the state-of-the-art results on all of these datasets with relatively low amount of labeled training data compared to other approaches.

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## Proposed Methodology

#### Loss Function No. of classes Unlabeled data Labeled data $\mathcal{L} = -\sum_{i} \left\| \sum_{i} y_{ic} \log p_{ic} + \sum_{i} w_{i} \hat{y}_{ic} \log p_{ic} \right\|$ $c=1 \ \lfloor i \in \mathcal{D}_L$ $i \in \mathcal{D}_I$ Pseudo-label of One-hot representation of image image *i* belonging to class *c* Weight for image *i* There are multiple ways this weight can be determined.

 $p_{ic}$  - Probability of image *i* belonging to the class *c*.

The proposed cross entropy based loss function is minimized to learn the parameters of the CNN. This loss function contains two terms, the first one is based on the labeled data  $(D_{I})$ , and the second one is based on the unlabeled data  $(D_{II})$ .

#### Weighting Schemes

- Equal weights for all the unlabeled images (*We*) confidence in prediction.
- probability (Ws)
- Soft-weighting based on probability (*Wp*) • Problem: Soft weights based on the probabilities.
- Weighting based on a margin criteria (*Wm*) (Proposed)

$$w_i = \frac{1}{1 + e^{-\beta}}$$

where, 
$$d = \hat{p}_i - \hat{p}'_i$$

## **Experiments and Results**

### Comparison of the weighting schemes on the NEU dataset

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Weighting Schemes	s N	Vs	Wp	Wm 98:34 ± 0:36	Methods	Overall accuracy (%) for different number of training samples per class					
Accuracy	97:10	) ± 0.84	$97{:}50\pm0{:}78$			9 (5%)	18 (10%)	45 (25%)	90 (50%)	180 (100%)	
					Supervised learning			·			
<b>Comparison</b>	with the state-of-the-a	art approacl	hes on the Kolek	tor SDD dataset	Zhou et. al.[4]	-	-	78.09	80.00	86.64	
Mothod		AP for diffe	rent number of po	sitive training samples	Li et. al. [5]	-	-	82.81	85.39	95.00	
Aethod		5	10	33	Ren et. al.[6]	-	-	_	90.88	92.04	
$Segmentation \ base$	ed approaches which us	e both image	and pixel level la	bels for training							
akob et. al. [11]		96.71	99.31	100	He et. al. (CAE-SGAN) [7]	-	-	-	-	98.96	
Tabernik et. al. [1	2]	95.80	98.80	99.00	He et. al. (cDCGAN) [8]	-	-	-	-	99.56	
Cognex ViDi (com	mercial software) [12]	89.20	95.60	99.00	We not all $(\mathbf{MMCCN})$ [0]					00 72	
mage level labels	only				wang et. al. (MMGCN) [9]	-	-	-	-	99.72	
Ku et. al. [13]		-	98.0	99.50	Ours	$91.69 \pm 1.52$	$97.00 \pm 0.09$	$99.45 \pm 0.26$	$99.67 \pm 0.17$	$99.86 \pm 0.11$	
Durs		$88.60 \pm 0.69$	$100 \pm 0.00$	$100 \pm 0.00$	Semi-supervised learning						
					He et. al. (CAE-SGAN) [7]	-	-	85.83	94.87	-	
Comparison wi	ith the state-of-the-ar	rt approache	es on the Surface	Textures dataset	He et al. (cDCGAN) [8]	-	-	89.58	96.06	-	
(ath a d	Accuracy for different	; percentage (	of labeled training	images	Gao et. al. (PLCNN) [10]	-	-	90.7*	-	-	
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						* Note: PLCNN[1	0] is trained with 50	) samples per class			

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Weighting Schemes		Ws	Wp	Wm		Overall accuracy (%) for different number of training samples per class					
Accuracy	97:10	0 ± 0.84	$97{:}50\pm0{:}78$	98:34 ± 0:36	Methods -	9 (5%)	18 (10%)	45 (25%)	90 (50%)	180 (100%)	
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						* Note: PLCNN[10] is trained with 50 samples per class					

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• Selection of a subset of unlabeled images based on prediction

• Problem: All the samples above a threshold are only considered.

- softness of the weight - maximum probability for image *i*  $\hat{p}'_{i}$  - second maximum probability for image i

• Soft weights based on how well each sample is classified.

## References



### Comparison with the state-of-the-art approaches on the NEU dataset



## Datasets